

Sheet 1 of 2
IDS LIST OF REFERENCES
CITED BY APPLICANT
(FORM PTO-1449)
DATED: December 12, 2005

Atty. Docket No.:
4929

Serial No.:
to be assigned

Applicant: Haruyo FUKUI et al.

U.S. Filing Date: December 12,
2005

Art Unit:

U. S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	Cl.	Sub- Cl.	File Date
A	AA	5,580,653	12/1996	Tanaka et al.	-	-	-
	AB	2003/0148145	08/2003	Yamamoto et al.	-	-	-
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A	AD	07-310174	11/1995	Japan	-	-	Abstract; =AA
	AE	09-295204	11/1997	Japan	-	-	Abstract
	AF	2000-087217	03/2000	Japan	-	-	Abstract
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	AK	2004-169076	06/2004	Japan	-	-	Abstract; = AC
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A	AM	2004-306228	11/2004	Japan	-	-	Abstract

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EXAMINER'S SIGNATURE



DATE CONSIDERED



9/07

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Sheet 2 of 2 IDS LIST OF REFERENCES CITED BY APPLICANT (FORM PTO-1449) DATED: December 12, 2005				Atty. Docket No.: 4929		Serial No.: to be assigned	
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	AN	S. Veprek et al., "Recent progress in the superhard nanocrystalline composites: towards their industrialization and understanding of the origin of the superhardness", Surface and Coatings Technology 108-109 (1998) 138-147; Elsevier Science S.A.					
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